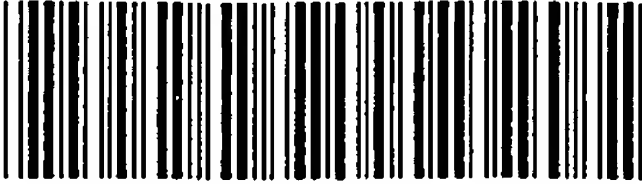


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/072,415	LEE ET AL.	
	Examiner	Art Unit	
	Steven J. Fulk	2891	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
313/309-310,336,351; 257/10,20,49-75; 438/20,149,151,155,180; 315/1+; 445/1+ (text search only - see search history printout)	1/25/2006	SJF